

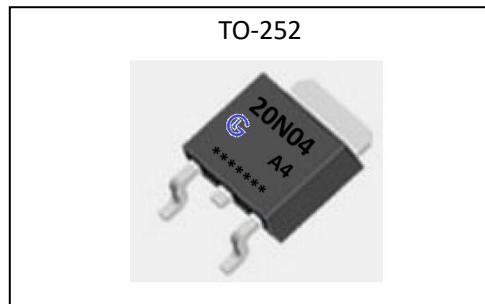
**General Description:**

The GL20N04A4 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications. The package form is TO-252, which accords with the RoHS standard.

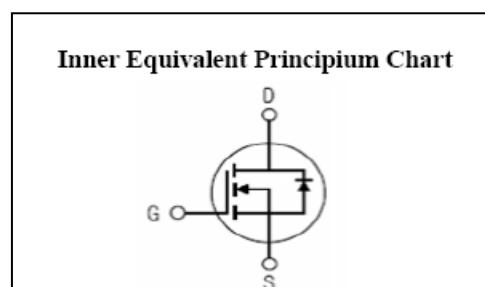
|                 |      |           |
|-----------------|------|-----------|
| $V_{DSS}$       | 40   | V         |
| $I_D$           | 20   | A         |
| $P_D$           | 32.5 | W         |
| $R_{DS(ON)MAX}$ | 25   | $m\Omega$ |

**Features:**

- $R_{DS(ON)} < 25m\Omega$  @  $V_{GS}=10V$
- High density cell design for ultra low  $R_{ds(on)}$
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation


**Applications:**

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply


**Absolute (T<sub>c</sub> = 25°C unless otherwise specified):**

| Symbol         | Parameter  | Rating          | Units |
|----------------|--|-----------------|-------|
| $V_{DSS}$      | Drain-to-Source Voltage                          | 40              | V     |
| $I_D$          | Continuous Drain Current                         | 20              | A     |
| $I_{DM}$       | Pulsed Drain Current                             | 80              | A     |
| $V_{GS}$       | Gate-to-Source Voltage                           | $\pm 20$        | V     |
| $P_D$          | Power Dissipation                                | 32.5            | W     |
| $T_J, T_{stg}$ | Operating Junction and Storage Temperature Range | 150, -55 to 150 | °C    |



# GL20N04A4

## GL Silicon N-Channel Power MOSFET

**Electrical Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified):

| OFF Characteristics |                                   |   |        |      |      |               |
|---------------------|-----------------------------------|---|--------|------|------|---------------|
| Symbol              | Parameter                         | Test Conditions                                 | Rating |      |      | Units         |
|                     |                                   |   | Min.   | Typ. | Max. |               |
| $V_{DSS}$           | Drain to Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu\text{A}$                 | 40     | --   | --   | V             |
| $I_{DSS}$           | Drain to Source Leakage Current   | $V_{DS}=40V, V_{GS} = 0V, T_a=25^\circ\text{C}$ | --     | --   | 1.0  | $\mu\text{A}$ |
| $I_{GSS(F)}$        | Gate to Source Forward Leakage    | $V_{GS}=+20V$                                   | --     | --   | 0.1  | $\mu\text{A}$ |
| $I_{GSS(R)}$        | Gate to Source Reverse Leakage    | $V_{GS}=-20V$                                   | --     | --   | -0.1 | $\mu\text{A}$ |

| ON Characteristics <sup>a3</sup> |                               |                                     |        |      |      |                  |
|----------------------------------|-------------------------------|-------------------------------------|--------|------|------|------------------|
| Symbol                           | Parameter                     | Test Conditions                     | Rating |      |      | Units            |
|                                  |                               |                                     | Min.   | Typ. | Max. |                  |
| $R_{DS(ON)}$                     | Drain-to-Source On-Resistance | $V_{GS}=10V, I_D=10A$               | --     | --   | 25   | $\text{m}\Omega$ |
| $V_{GS(\text{TH})}$              | Gate Threshold Voltage        | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$ | 1.0    | --   | 2.5  | V                |

Pulse width  $t_p \leq 380\mu\text{s}, \delta \leq 2\%$

| Dynamic Characteristics <sup>a4</sup> |                              |                         |        |      |      |       |
|---------------------------------------|------------------------------|-------------------------|--------|------|------|-------|
| Symbol                                | Parameter                    | Test Conditions         | Rating |      |      | Units |
|                                       |                              |                         | Min.   | Typ. | Max. |       |
| $g_{fs}$                              | Forward Transconductance     | $V_{DS}=15V, I_D=2A$    | --     | 3    | --   | S     |
| $C_{iss}$                             | Input Capacitance            | $V_{GS}=0V, V_{DS}=20V$ | --     | 247  | --   | pF    |
| $C_{oss}$                             | Output Capacitance           | $f=1.0\text{MHz}$       | --     | 34   | --   |       |
| $C_{rss}$                             | Reverse Transfer Capacitance |                         | --     | 19.5 | --   |       |

| Resistive Switching Characteristics <sup>a4</sup> |                                  |                      |        |      |      |       |
|---|----------------------------------|----------------------|--------|------|------|-------|
| Symbol  | Parameter                        | Test Conditions      | Rating |      |      | Units |
|   |                                  |                      | Min.   | Typ. | Max. |       |
| $t_{d(ON)}$                                       | Turn-on Delay Time               | $V_{DD}=20V, I_D=3A$ | --     | 6    | --   | ns    |
| $t_r$   | Rise Time                        |                      | --     | 15   | --   |       |
| $t_{d(OFF)}$                                      | Turn-Off Delay Time              |                      | --     | 15   | --   |       |
| $t_f$   | Fall Time                        |                      | --     | 10   | --   |       |
| $Q_g$   | Total Gate Charge                | $V_{DD}=20V, I_D=3A$ | --     | 6    | --   | nC    |
| $Q_{gs}$  | Gate to Source Charge            |                      | --     | 1    | --   |       |
| $Q_{gd}$  | Gate to Drain ( "Miller" )Charge |                      | --     | 1.3  | --   |       |



# GL20N04A4

## GL Silicon N-Channel Power MOSFET

### Source-Drain Diode Characteristics

| Symbol          | Parameter  | Test Conditions                          | Rating |      |      | Units |
|-----------------|--|--|--------|------|------|-------|
|                 |  |  | Min.   | Typ. | Max. |       |
| I <sub>S</sub>  | Continuous Source Current <sup>a2</sup> (Body Diode) |  | --     | --   | 20   | A     |
| V <sub>SD</sub> | Diode Forward Voltage <sup>a3</sup>                  | I <sub>S</sub> =20A, V <sub>GS</sub> =0V | --     | --   | 1.5  | V     |

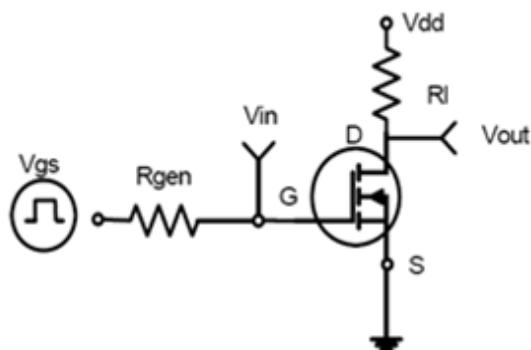
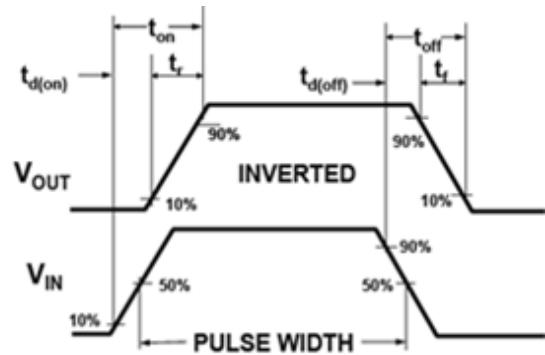
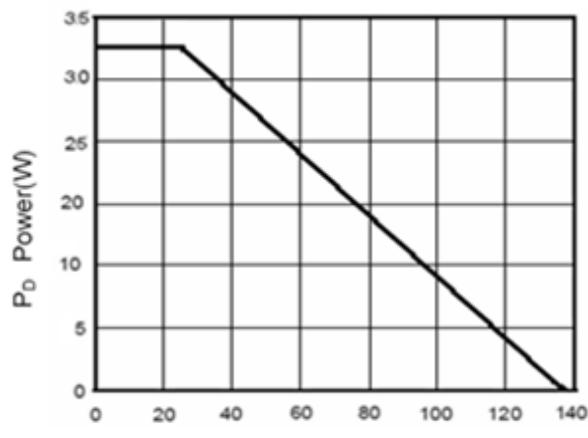
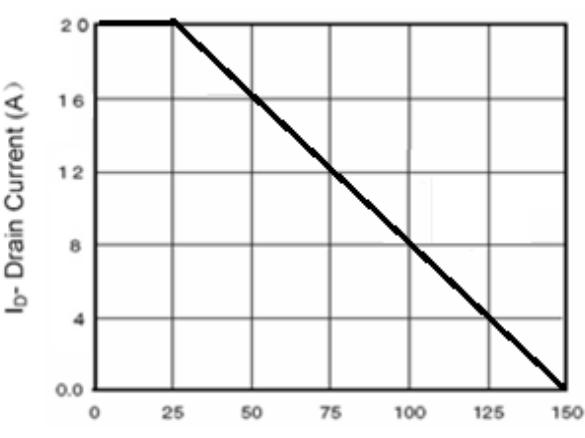
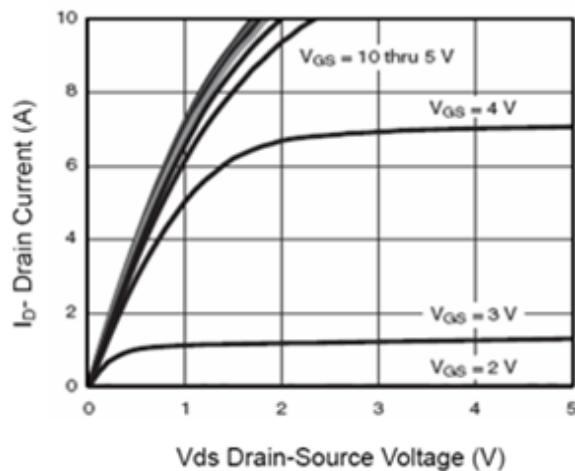
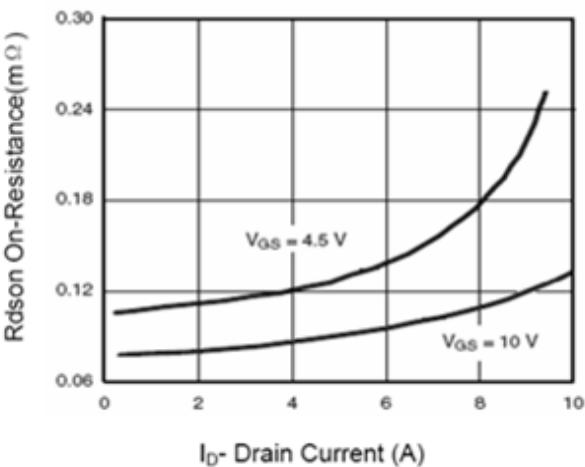
| Symbol           | Parameter                      | Typ.  | Units |
|------------------|--------------------------------|-------|-------|
| R <sub>θJC</sub> | Junction-to-Case <sup>a2</sup> | 3.846 | °C/W  |

<sup>a1</sup>: Repetitive Rating: Pulse width limited by maximum junction temperature.

<sup>a2</sup>: Surface Mounted on FR4 Board, t≤10sec.

<sup>a3</sup>: Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%.

<sup>a4</sup>: Guaranteed by design, not subject to production

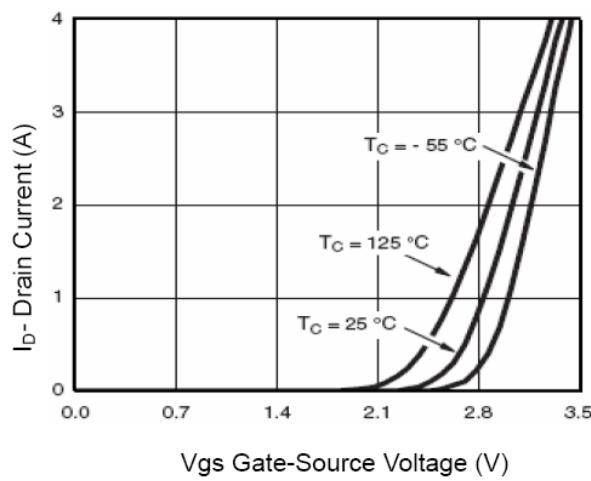
**Characteristics Curve:**

**Figure 1:Switching Test Circuit**

**Figure 2:Switching Waveforms**

**Figure 3 Power Dissipation**

**Figure 4 Drain Current**

**Figure 5 Output Characteristics**

**Figure 6 Drain-Source On-Resistance**



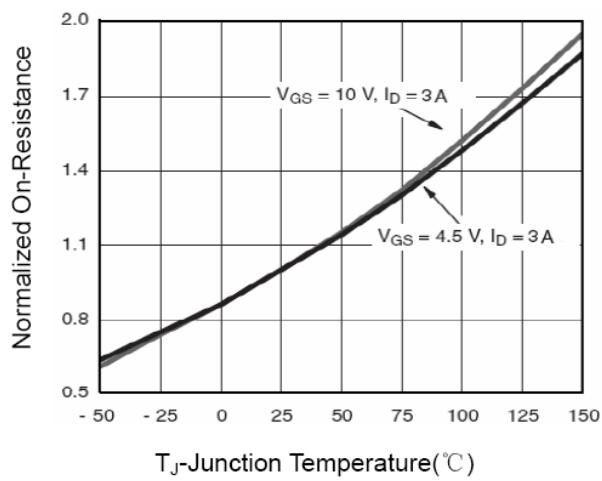
®

# GL20N04A4

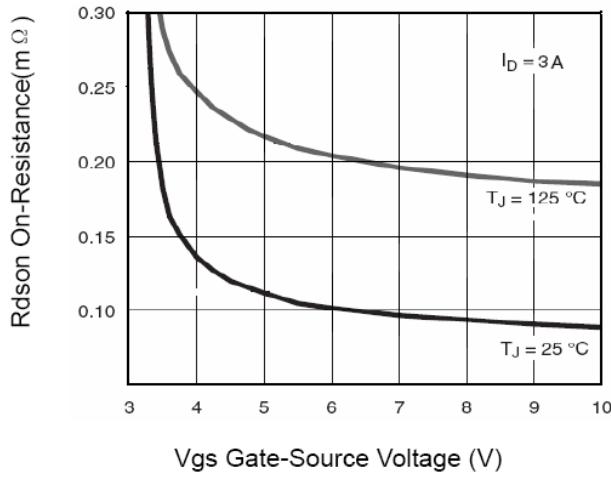
## GL Silicon N-Channel Power MOSFET



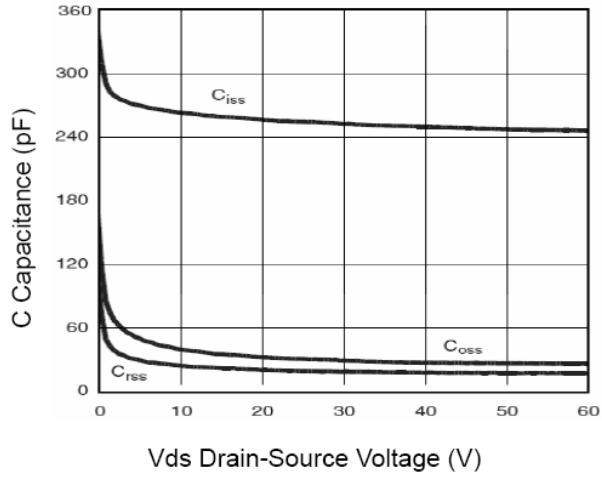
**Figure 7 Transfer Characteristics**



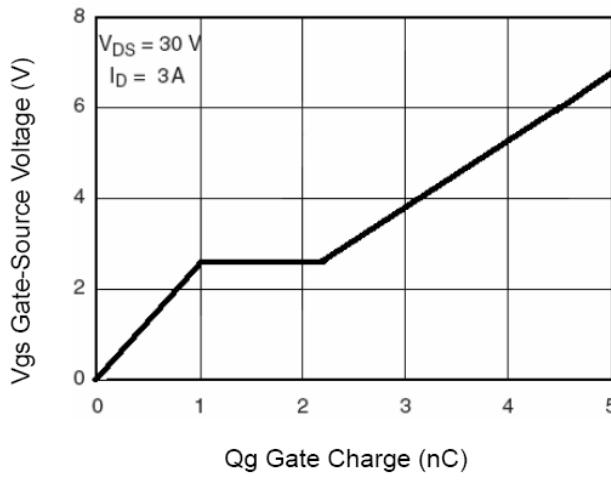
**Figure 8 Drain-Source On-Resistance**



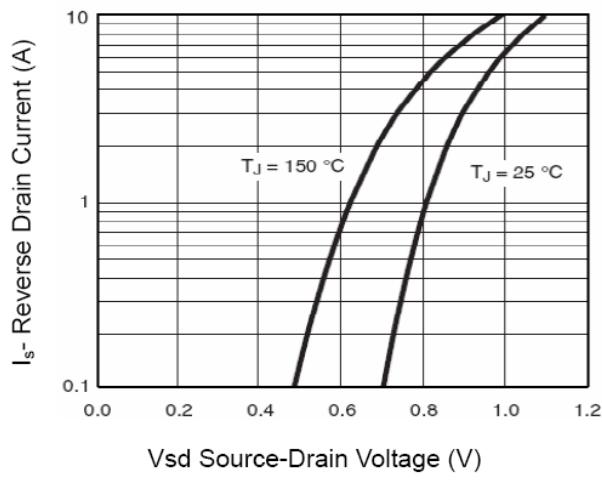
**Figure 9  $R_{DS(on)}$  vs  $V_{GS}$**



**Figure 10 Capacitance vs  $V_{DS}$**



**Figure 11 Gate Charge**



**Figure 12 Source-Drain Diode Forward**